TOSHIBA Field Effect Transistor Silicon N-Channel MOS Type (π -MOSIV)

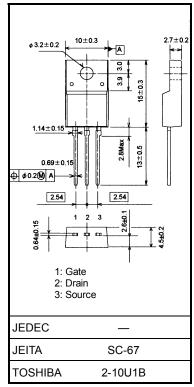
2SK4014

DC/DC Converter, Relay Drive and Motor Drive Applications

- Low drain-source ON-resistance : $R_{DS (ON)} = 1.6 \Omega (typ.)$
- High forward transfer admittance $(Y_{fs}) = 5.0 \text{ S (typ.)}$
- Low leakage current : I_{DSS} = 100 A (max) (V_{DS} = 720 V)
- Enhancement mode : $V_{th} = 2.0 4.0 V (V_{DS} = 10 V, I_D = 1 mA)$

Maximum Ratings (Ta = 25°C)

Character	stic	Symbol	Rating	Unit
Drain-source voltage		V _{DSS}	900	V
Drain-gate voltage (R	_{GS} = 20 kΩ)	V _{DGR}	900	V
Gate-source voltage		V _{GSS}	±30	V
Drain current	DC (Note 1)	I _D	6	А
	Pulse (Note 1)	I _{DP}	18	А
Drain power dissipation	n (Tc = 25°C)	PD	45	W
Single-pulse avalanche energy (Note 2)		E _{AS}	972	mJ
Avalanche current		I _{AR}	6	А
Repetitive avalanche e	energy (Note 3)	E _{AR}	15	mJ
Channel temperature		T _{ch}	150	°C
Storage temperature ra	ange	T _{stg}	-55~150	°C



Weight: 1.7 (typ.)

Thermal Characteristics

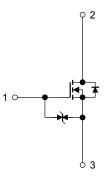
Characteristic	Symbol	Мах	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	2.78	°C / W
Thermal resistance, channel to ambient	R _{th (ch−a)}	62.5	°C / W

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: V_{DD} = 90 V, T_{ch} = 25°C (initial), L = 49.5 mH, R_G = 25 Ω , I_{AR} = 6 A

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Handle with care.



Unit: mm

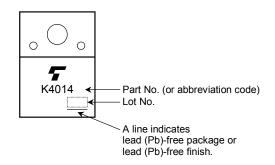
Electrical Characteristics (Ta = 25°C)

Chara	cteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	V _{GS} = ±30 V, V _{DS} = 0 V		—	±10	μA
Gate-source br	eakdown voltage	V (BR) GSS	I _G = ±10 μA, V _{DS} = 0 V				V
Drain cutoff curr	rent	I _{DSS}	V _{DS} = 720 V, V _{GS} = 0 V	_	_	100	μA
Drain-source bi	reakdown voltage	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	900	_	_	V
Gate threshold	voltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	2.0	_	4.0	V
Drain-source O	N-resistance	R _{DS (ON)}	V _{GS} = 10 V, I _D = 3 A	_	1.6	2.0	Ω
Forward transfe	r admittance	Y _{fs}	V _{DS} = 10 V, I _D = 3 A	_	5.0	_	S
Input capacitance Reverse transfer capacitance		C _{iss}		_	1400	_	
		C _{rss}	V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz	_	30	_	pF
Output capacitance		C _{oss}			130	_	
Switching time	Rise time	tr	$V_{GS} \stackrel{10V}{_{0V}} \prod_{i=1\\ i=3\\ 0\\ i=1\\ i=1\\ i=1\\ i=1\\ i=1\\ i=1\\ i=1\\ i=1$	_	25	_	
	Turn-on time	t _{on}		_	75	_	ns
	Fall time	t _f		_	60	_	115
	Turn-off time	t _{off}	$V_{DD} = 400 V$ Duty $\leq 1\%$, t _w =10µs	_	220	_	
Total gate charge (gate-source plus gate-drain)		Qg	V _{DD} ≈ 400 V, V _{GS} = 10 V, I _D = 6 A		45	_	nC
Gate-source charge		Q _{gs}			25	_	
Gate-drain ("Miller") charge		Q _{gd}		_	20	_	

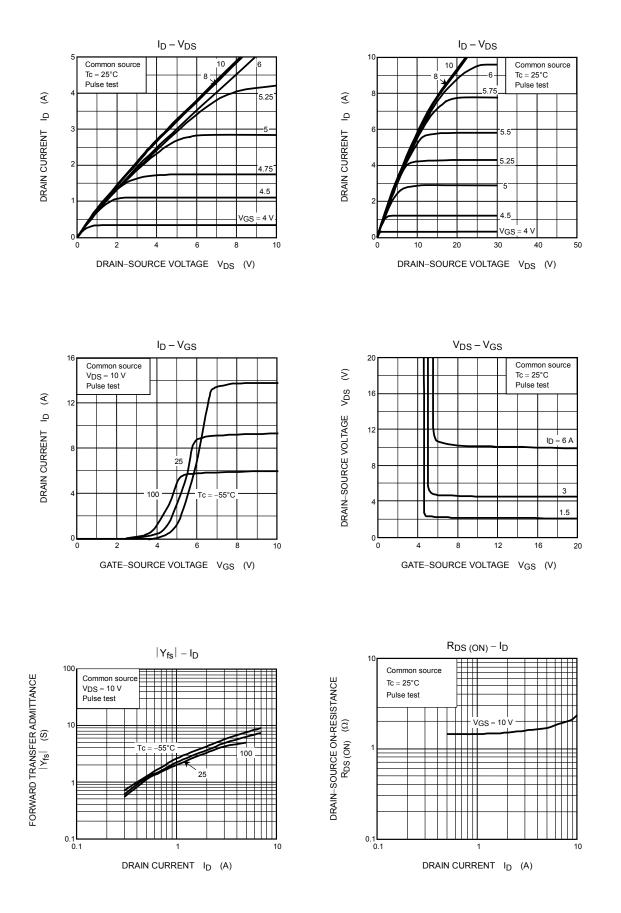
Source–Drain Ratings and Characteristics (Ta = 25°C)

Characteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	-	-	6	А
Pulse drain reverse current (Note 1)	I _{DRP}	—	_	_	18	А
Forward voltage (diode)	V _{DSF}	I _{DR} = 6 A, V _{GS} = 0 V	_	_	-1.7	V
Reverse recovery time	t _{rr}	I _{DR} = 6 A, V _{GS} = 0 V dI _{DR} / dt = 100 A / μs		1100		ns
Reverse recovery charge	Q _{rr}	dI _{DR} / dt = 100 A / μs	-	10	-	μC

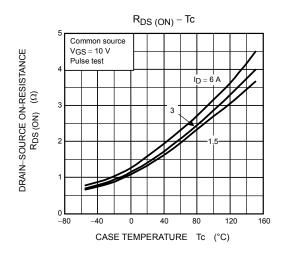
Marking

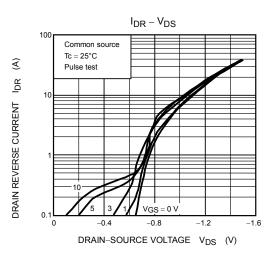


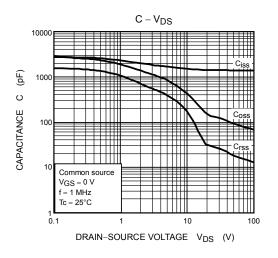
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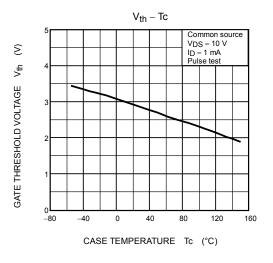


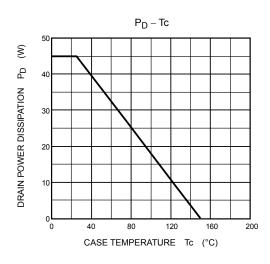
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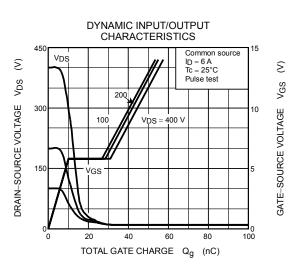


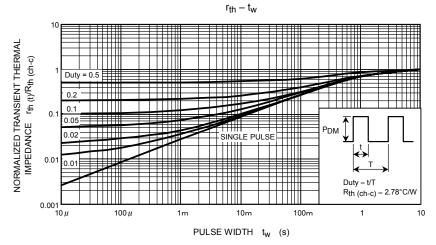


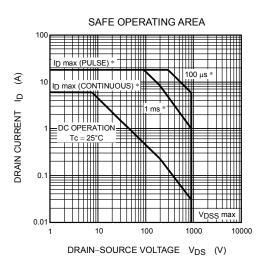


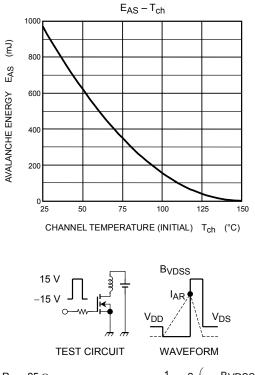












$$\begin{array}{l} \mathsf{R}_{G} = 25 \ \Omega \\ \mathsf{V}_{DD} = 90 \ \mathsf{V}, \ \mathsf{L} = 49.5 \ \mathsf{mH} \end{array} \qquad \mathsf{E}_{AS} = \frac{1}{2} \cdot \mathsf{L} \cdot \mathsf{I}^{2} \cdot \left(\frac{\mathsf{B}_{VDSS}}{\mathsf{B}_{VDSS} - \mathsf{V}_{DD}} \right) \end{array}$$

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